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Electrostatics – Part 2-1: Measurement methods – Ability of materials and products to dissipate static electric charge

Électrostatique – Partie 2-1: Méthodes de mesure – Capacité des matériaux et des produits à dissiper des charges électrostatiques



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Electrostatics – iTeh STANDARD PREVIEW
Part 2-1: Measurement methods – Ability of materials and products to dissipate static electric charge
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Partie 2-1: Méthodes de mesure – Capacité des matériaux et des produits à dissiper des charges électrostatiques
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ELECTROSTATICS –

**Part 2-1: Measurement methods –
Ability of materials and products
to dissipate static electric charge**

FOREWORD

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International Standard IEC 61340-2-1 has been prepared by IEC technical committee 101: Electrostatics.

This second edition cancels and replaces the first edition published in 2002. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) the first edition supported requirements in IEC TR 61340-5-1, but with the revision of IEC TR 61340-5-1 into an International Standard, this support is no longer required; references to IEC 61340-5-1[1]¹ have been removed;
- b) the introduction gives additional information on when charge decay time measurements are appropriate, and the applications for which each of the two test methods are best suited;
- c) procedures for performance verification of measuring instruments for the corona charging method have been added.

The text of this standard is based on the following documents:

| CDV | Report on voting |
|-------------|------------------|
| 101/446/CDV | 101/462/RVC |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

It has the status of a horizontal standard in accordance with IEC Guide 108[3].

A list of all the parts in the IEC 61340 series, published under the general title *Electrostatics*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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- withdrawn,
- replaced by a revised edition, or
- amended.

¹ Numbers in square brackets refer to the Bibliography.

INTRODUCTION

Measurements of the rate of dissipation of static charge belong to the essential measurement techniques in the field of electrostatics.

For homogeneous conductive materials, this property can be evaluated indirectly by measuring resistance or resistivity parameters. Care should be exercised when determining the homogeneity of materials, as some materials that appear homogenous do exhibit non-homogeneous electrical characteristics. If the homogeneity of materials is not known and cannot be otherwise verified, resistance measurements may not be reliable or may not give enough information. Resistance measurements may also not be reliable when evaluating materials in the dissipative or insulative range and especially for high ohmic materials including conductive fibres (e.g. textiles with a metallic grid). In such cases, the rate of dissipation of static charge should be measured directly.

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ELECTROSTATICS –

Part 2-1: Measurement methods –

Ability of materials and products

to dissipate static electric charge

1 Scope

This part of IEC 61340 describes test methods for measuring the rate of dissipation of static charge of insulating and static dissipative materials and products.

It includes a generic description of test methods and detailed test procedures for specific applications.

The two test methods for measuring charge decay time, one using corona charging and one using a charged metal plate are different and may not give equivalent results. Nevertheless, each method has a range of applications for which it is best suited. The corona charging method is suitable for evaluating the ability of materials, e.g. textiles, packaging, etc., to dissipate charge from their own surfaces. The charged metal plate method is suitable for evaluating the ability of materials and objects such as gloves, finger cots, hand tools, etc. to dissipate charge from conductive objects placed on or in contact with them. The charged plate method may not be suitable for evaluating the ability of materials to dissipate charge from their own surfaces.

In addition to its general application, this horizontal standard is also intended for use by technical committees in the preparation of standards in accordance with the principles laid down in IEC Guide 108.

One of the responsibilities of a technical committee is, wherever applicable, to make use of horizontal standards in the preparation of its publications. The contents of this horizontal standard shall not apply unless specifically referred to or included in the relevant publications.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61340-4-6, *Electrostatics – Part 4-6: Standard test methods for specific applications – Wrist straps*

IEC 61340-4-7, *Electrostatics – Part 4-7: Standard test methods for specific applications – Ionization*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1

charge decay

migration of charge across or through a material leading to a reduction of charge density or surface potential at the area where the charge was deposited

3.2

charge decay time

time from an initial voltage to a set fraction of the initial voltage

Note 1 to entry: $1/e$ and 10 % are appropriate fractions (e is the base of natural logarithms, equal to 2,718). If the initial voltage is low, the accuracy of decay time measurements to a small fraction of the initial voltage may be susceptible to the noise level of the fieldmeter.

3.3

charged plate monitor

CPM

instrument using a charged metal plate of a defined capacitance and geometry which is discharged in order to measure charge dissipation/neutralization properties of products or materials

Note 1 to entry: This note only applies to the French language.

3.4

corona

corona discharge

generation of ions of either polarities by a high electric field

3.5

static dissipative material

material which allows charge to migrate over its surface and/or through its volume in a time which is short compared to the time scale of the actions creating the charge, or short compared to the time within which this charge will cause an electrostatic problem

Note 1 to entry: Materials that may be considered conductive in other contexts are included within this definition for the purposes of this part of IEC 61340.

3.6

initial voltage

< corona charge decay> surface potential at a time after the end of charge deposition that is a sensible match to the time it takes material surfaces to separate in practical situations

Note 1 to entry: A time of 100 ms is appropriate for manual tribocharging actions.

3.7

initial voltage

<contact charge decay> voltage applied to the conductive plate of a charged plate monitor

3.8

insulator

material with very low mobility of charge so that any charge on the surface will remain there for a time which is long compared to the time scale of the actions creating the charge

4 Method of measurement of charge decay

4.1 Principles

Two methods are described.

The first method determines the dissipation of charge deposited on the surface of the material by a corona discharge. The resulting decrease in surface potential is observed using a

fieldmeter or other equivalent equipment. This method is applicable to measurement of charge dissipation from surfaces and materials.

The second method determines the dissipation of charge from a charged plate through an object under test by applying a potential to the metallic plate, disconnecting the voltage source and observing the decrease in potential of the plate by means of a fieldmeter or other equivalent equipment. This method is applicable to measurement of charge dissipation via products such as finger cots, gloves and hand tools.

NOTE There are more methods to charge materials other than the charging methods described here (for example tribocharging or inductive charging) but they are not relevant for this standard.

CAUTION The test methods specified in this International Standard involve the use of high-voltage power supplies that may present hazards if handled incorrectly, particularly by unqualified or inexperienced personnel. Users of this International Standard are encouraged to carry out proper risk assessments and pay due regard to local regulations before undertaking any of the test procedures.

4.2 Environmental conditions

The electrical properties of materials vary with temperature and the absorption of moisture.

Unless otherwise agreed, the atmosphere for conditioning and testing shall be $(23 \pm 2) ^\circ\text{C}$ and $(12 \pm 3) \%$ relative humidity, and the conditioning time prior to testing shall be at least 48 h.

For measurements in practical situations the ambient temperature and relative humidity shall be recorded.

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The test aperture for deposition and measurement of deposited charge shall be (50 ± 1) mm diameter or an equivalent area quasi-square aperture. An array of corona points is mounted on a movable plate above the centre of the test aperture. The fieldmeter sensing aperture shall be (25 ± 1) mm above the centre of the test area. When the plate with the corona points is moved fully away, the test area shall be clear up to the plane of the fieldmeter sensing aperture.

4.3.2 Containment of test material

With an installed material, the test aperture in the instrument base plate shall rest directly on its surface. Sheet or flexible materials shall be supported as follows:

- a) for testing materials with open backing, the material shall be rested against an earthed metal plate with an aperture aligned with the instrument test aperture and with a width of at least 5 mm extending beyond the aperture. A shield over the reverse side of the test area shall be earthed and be at least 25 mm away over the whole test area;
- b) for testing materials against an earthed backing, the material shall be mounted between the instrument base plate and a flat earthed metal plate.

NOTE If charge moves more readily through the bulk test material than across its surface, then placing an earthed metal plate immediately behind the test area can increase the rate of charge dissipation. On the other hand, if charge moves more readily across the surface of the test material, then the rate of charge dissipation can decrease if an earthed metal plate is used because its presence will increase the capacitive loading. To gain a full understanding of charge dissipation from the test material, it is desirable to make measurements both with and without an earthed metal plate backing the test area.

In practical terms, earthed backing represents a material in intimate contact with an earthed surface, for example, a garment fitted close to the body of the wearer, or a work surface on top of a metal bench. Open-backed measurements represent the other practical extreme where materials are separated from earthed surfaces, for example, the bottom edge of a coat or smock which hangs away from the body of the wearer.

4.3.3 Corona charge deposition IEC 61340-2-1:2015

Corona charging is achieved with at least five corona points, the tips of which form a (10 ± 1) mm diameter circle, (10 ± 1) mm above the centre of the test area. The corona points shall be made from non-corrosive metal wire of a diameter in the range 0,1 mm to 0,5 mm. The exact size and distribution of charge on the material is not well defined, particularly with the more conductive surfaces, but the arrangement provides a consistent pattern of deposited charge and decay time measurements.

NOTE 1 Typical voltages for corona charging equipment are between 5 kV and 10 kV.

The corona duration shall be no more than 50 ms, and 10 ms or 20 ms is usually appropriate in order to achieve an adequate initial peak voltage for measurements. Excessively long deposition times (more than some seconds) may damage the material.

The materials shall be tested with positive and negative polarity.

The equipment for charge deposition shall move fully away from the region of fieldmeter observation in less than 20 ms.

NOTE 2 For corona voltages of 7 kV to 8 kV, the initial surface voltage with relatively high insulating materials will be up to about 3 kV. For materials with fast charge decay rates the initial voltage can be much lower – for example only 50 V to 100 V.

4.3.4 Fieldmeter

The fieldmeter shall be able to measure the surface voltage with an accuracy of ± 5 V to below the lower limit of surface voltage that is required to be measured. The response time (10 % to 90 %) shall be at least one-tenth of the faster decay time required to be measured. The stability of the zero shall allow measurement of surface voltage with this accuracy over the longest decay times to be measured. Therefore, a rotating vane 'field mill' type of fieldmeter is preferred.

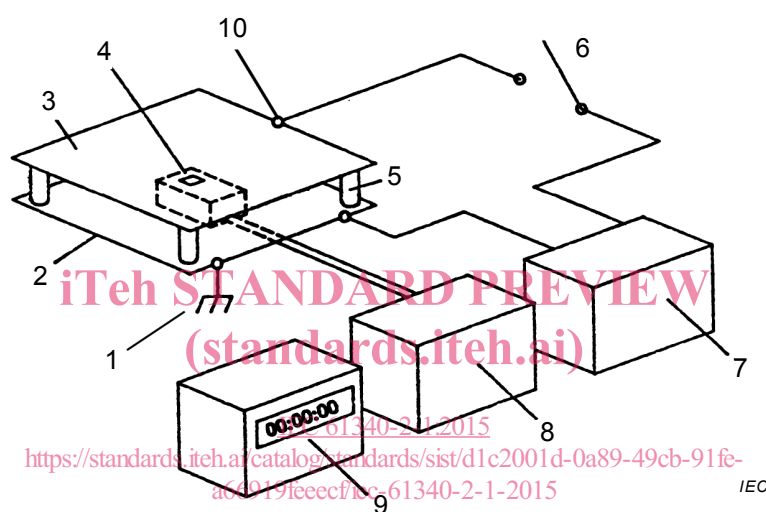
During corona charge deposition and decay time measurement, the fieldmeter sensing aperture shall be well shielded from any connections or surfaces associated with corona high-voltage supplies. There shall be no insulating materials around the region between the fieldmeter and the test aperture during the operation of the fieldmeter.

Any residual ionization shall contribute less than 20 V to the measurement of the surface voltage (excess ionization may be removed, for example, by using an air dam). This may be tested by measurements on a fully conducting test surface.

4.4 Apparatus for measurement of contact charge decay

4.4.1 Physical design features

The basic arrangement and relevant dimensions of the test apparatus are shown in Figure 2. Other equipment giving similar results may be used.



Key

- 1 Ground
- 2 Grounded surface, greater than 150 mm square
- 3 Conductive plate (150 ± 1) mm × (150 ± 1) mm
- 4 Probe
- 5 Supporting insulator (resistance to ground > 10¹⁴ Ω)
- 6 Switch
- 7 High-voltage power supply – current limited
- 8 Fieldmeter or equivalent
- 9 Discharge timer
- 10 High-voltage plate contact

Figure 2 – Example of an arrangement for measurement of dissipation of charge using a charged plate²

The instrument to measure the charge dissipation of objects under test is the charged plate monitor (see Figure 2). The conductive plate shall be (150 ± 1) mm × (150 ± 1) mm with a capacitance of 20 pF ± 2 pF when mounted in the test fixture. The wire between the switch and the plate shall be as short as possible.

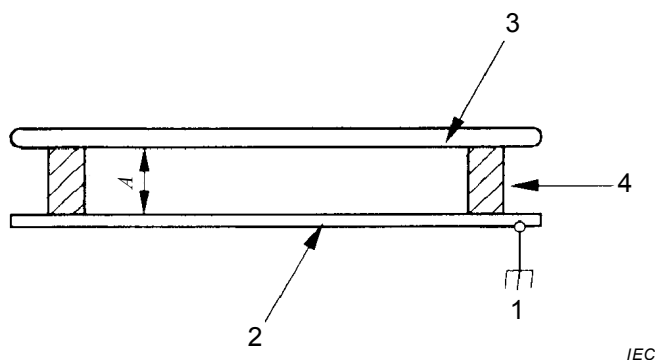
There shall be no objects grounded or otherwise closer than dimension *A* of Figure 3 to the conductive plate, except the supporting insulators as shown in Figures 2 and 3, or the high-voltage plate contact as shown in Figure 2. The resistance to ground of the supporting insulators shall be >10¹⁴ Ω. Dimension *A* is selected to achieve the desired capacitance. The

² If the different components are integrated into one instrument, this is referred to as a charged plate monitor (CPM).

isolated conductive plate, when charged to the desired test voltage, shall not discharge more than 10 % of the test voltage within 5 min under the environmental conditions specified in 4.2. The response time of the monitoring device shall be sufficient to accurately measure charging plate voltages.

The capacitance of the plate and the wires shall be determined according to Clause A.2.

Further design requirements, including requirements for alternative charged plate monitor designs, are specified in IEC 61340-4-7.



Key

- 1 Ground
- 2 Grounded surface, greater than 150 mm square
- 3 Conductive plate (150 ± 1) mm × (150 ± 1) mm
- 4 Supporting insulator

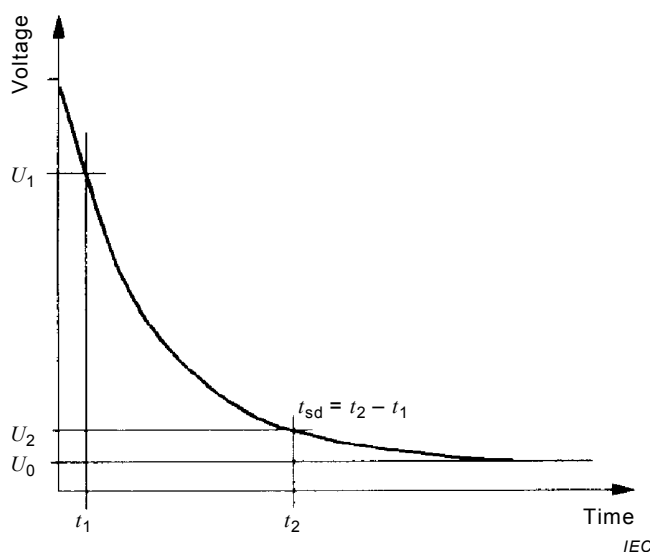
Figure 3 – Charged plate detail

4.4.2 Charge decay time (t_{sd})

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The charge decay time is the period to reduce the initial voltage U_1 on the charged plate to a defined lower voltage level U_2 , for example the time from 1 000 V to 100 V for positive or negative polarity (see Figure 4).

There may be occasions when the potential decay approaches a non-zero value. This final offset voltage is designated U_0 .



NOTE The decay curve may or may not go down to 0 V.

Figure 4 – Charge decay time (t_{sd}) and offset voltage (U_0)